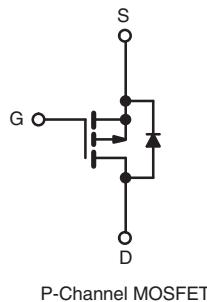
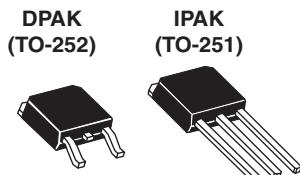




KERSEMI

Power MOSFET

PRODUCT SUMMARY		
V _{DS} (V)	- 60	
R _{DS(on)} (Ω)	V _{GS} = - 10 V	0.28
Q _g (Max.) (nC)	19	
Q _{gs} (nC)	5.4	
Q _{gd} (nC)	11	
Configuration	Single	



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Surface Mount (IRFR9024/SiHFR9024)
- Straight Lead (IRFU9024/SiHFU9024)
- Available in Tape and Reel
- P-Channel
- Fast Switching
- Lead (Pb)-free Available

RoHS*
COMPLIANT

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The DPAK is designed for surface mounting using vapor phase, infrared, or wave soldering techniques. The straight lead version (IRFU/SiHFU series) is for through-hole mounting applications. Power dissipation levels up to 1.5 W are possible in typical surface mount applications.

ORDERING INFORMATION					
Package	DPAK (TO-252)	DPAK (TO-252)	DPAK (TO-252)	DPAK (TO-252)	IPAK (TO-251)
Lead (Pb)-free	IRFR9024PbF	IRFR9024TRPbFa	IRFR9024TRLPbFa	IRFR9024TRRPbFa	IRFU9024PbF
	SiHFR9024-E3	SiHFR9024T-E3a	SiHFR9024TL-E3a	SiHFR9024TR-E3a	SiHFU9024-E3
SnPb	IRFR9024	IRFR9024TRa	IRFR9024TRLa	-	IRFU9024
	SiHFR9024	SiHFR9024Ta	SiHFR9024TLa	-	SiHFU9024

Note

a. See device orientation.

ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted					
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V _{DS}	- 60	
Gate-Source Voltage			V _{GS}	± 20	V
Continuous Drain Current	V _{GS} at - 10 V	T _C = 25 °C	I _D	- 8.8	
		T _C = 100 °C		- 5.6	A
Pulsed Drain Current ^a			I _{DM}	- 35	
Linear Derating Factor				0.33	
Linear Derating Factor (PCB Mount) ^e				0.020	W/°C
Single Pulse Avalanche Energy ^b			E _{AS}	300	mJ
Repetitive Avalanche Current ^a			I _{AR}	- 8.8	A
Repetitive Avalanche Energy ^a			E _{AR}	5.0	mJ
Maximum Power Dissipation	T _C = 25 °C		P _D	42	
Maximum Power Dissipation (PCB Mount) ^e	T _A = 25 °C			2.5	W
Peak Diode Recovery dV/dt ^c			dV/dt	- 4.5	V/ns
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	
Soldering Recommendations (Peak Temperature)	for 10 s			260 ^d	°C

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. V_{DD} = - 25 V, starting T_J = 25 °C, L = 4.5 mH, R_G = 25 Ω, I_{AS} = - 8.8 A (see fig. 12).c. I_{SD} ≤ - 11 A, dI/dt ≤ 140 A/μs, V_{DD} ≤ V_{DS}, T_J ≤ 150 °C.

d. 1.6 mm from case.

e. When mounted on 1" square PCB (FR-4 or G-10 material).

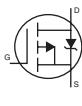
THERMAL RESISTANCE RATINGS

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	-	110	°C/W
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-	-	50	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	-	3.0	

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

SPECIFICATIONS T_J = 25 °C, unless otherwise noted

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA		- 60	-	-	V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	Reference to 25 °C, I _D = 1 mA		-	- 0.063	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA		- 2.0	-	- 4.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 60 V, V _{GS} = 0 V		-	-	- 100	μA
		V _{DS} = - 48 V, V _{GS} = 0 V, T _J = 125 °C		-	-	- 500	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D = - 5.3 A ^b	-	-	0.28	Ω
Forward Transconductance	g _{fs}	V _{DS} = - 25 V, I _D = - 5.3 A		2.9	-	-	S
Dynamic							
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = - 25 V, f = 1.0 MHz		-	570	-	pF
Output Capacitance	C _{oss}			-	360	-	
Reverse Transfer Capacitance	C _{rss}			-	65	-	
Total Gate Charge	Q _g	V _{GS} = - 10 V	I _D = - 11 A, V _{DS} = - 48 V, see fig. 6 and 13 ^b	-	-	19	nC
Gate-Source Charge	Q _{gs}			-	-	5.4	
Gate-Drain Charge	Q _{gd}			-	-	11	
Turn-On Delay Time	t _{d(on)}	V _{DD} = - 30 V, I _D = - 11 A, R _G = 18 Ω, R _D = 2.5 Ω, see fig. 10 ^b		-	13	-	ns
Rise Time	t _r		-	68	-		
Turn-Off Delay Time	t _{d(off)}		-	15	-		
Fall Time	t _f		-	29	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH
Internal Source Inductance	L _S			-	7.5	-	
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	- 8.8	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	- 35	
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = - 8.8 A, V _{GS} = 0 V ^b		-	-	- 6.3	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = - 11 A, dI/dt = 100 A/μs ^b		-	100	200	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.32	0.64	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 μs; duty cycle ≤ 2 %.



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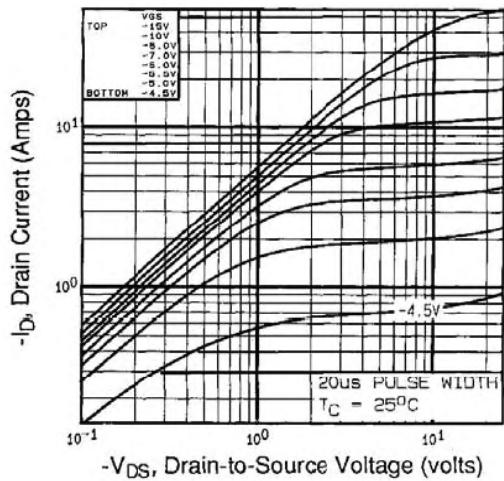
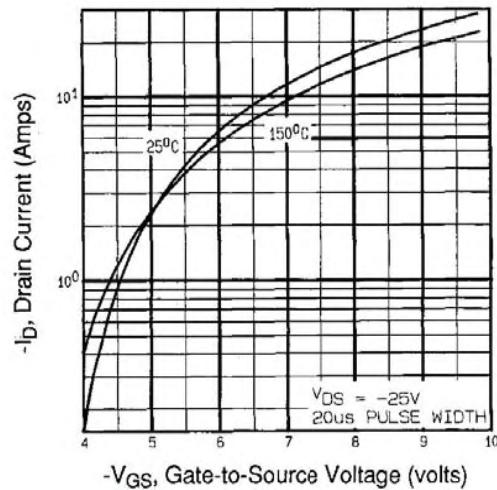
TYPICAL CHARACTERISTICS 25 °C, unless otherwise notedFig. 1 - Typical Output Characteristics, $T_C = 25$ °C

Fig. 3 - Typical Transfer Characteristics

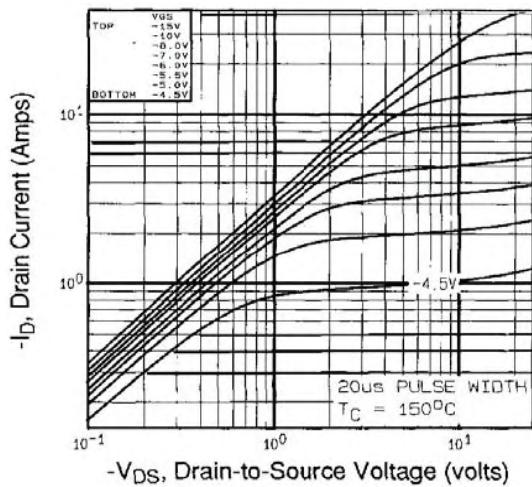
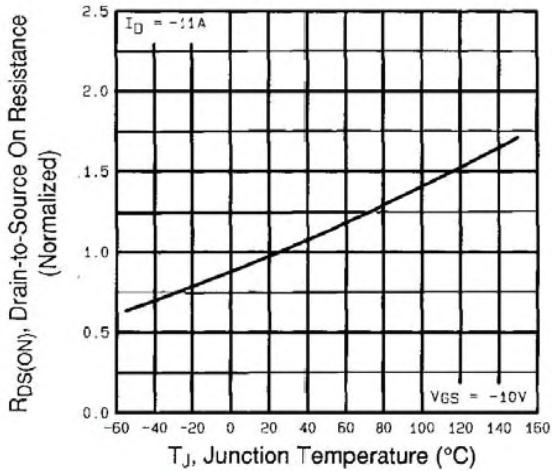
Fig. 2 -Typical Output Characteristics, $T_C = 150$ °C

Fig. 4 - Normalized On-Resistance vs. Temperature

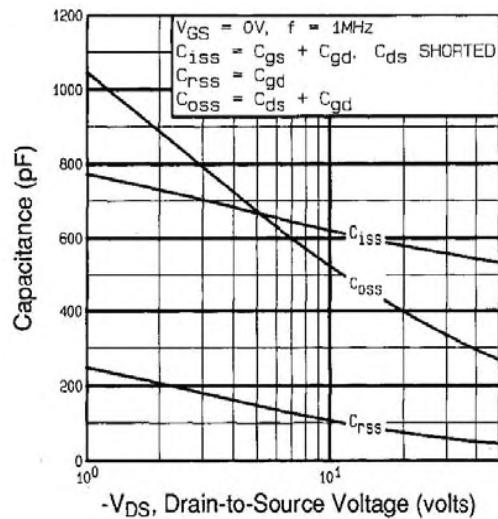
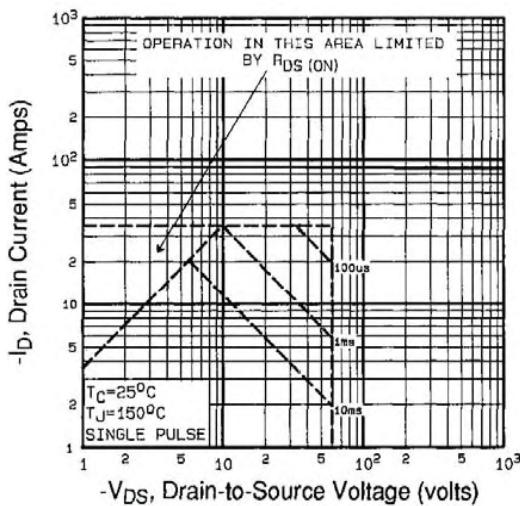
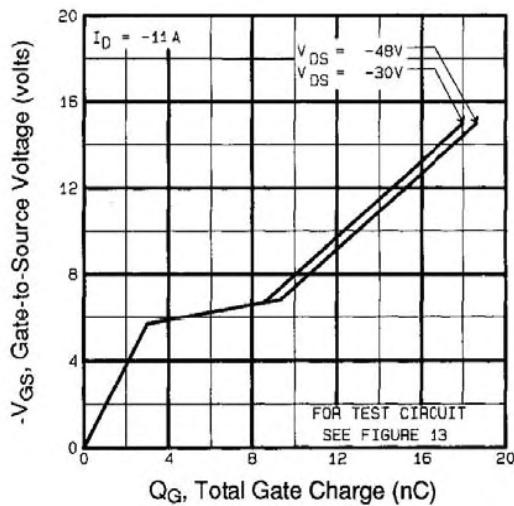
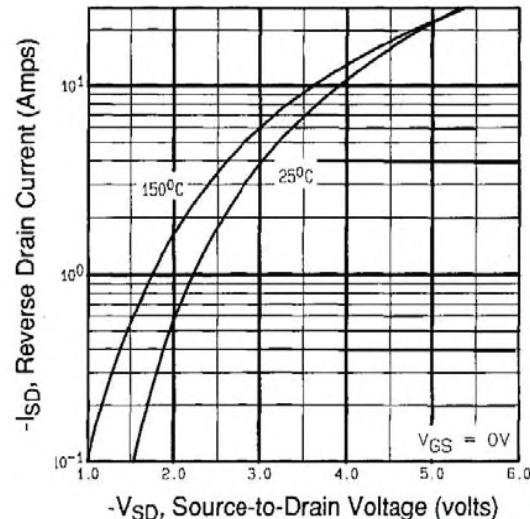


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



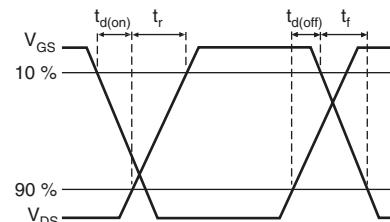
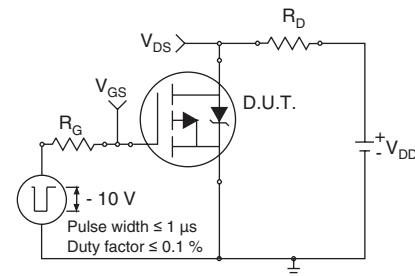
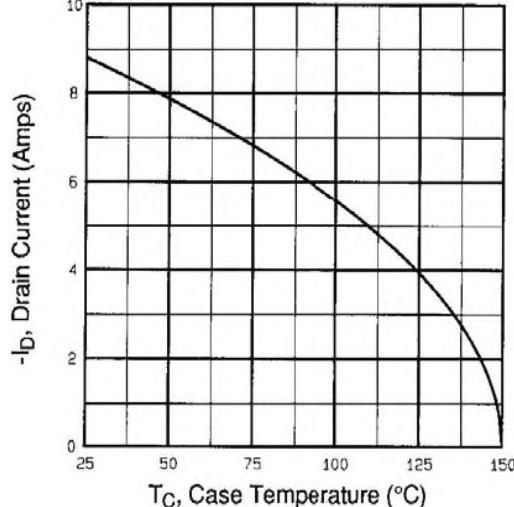
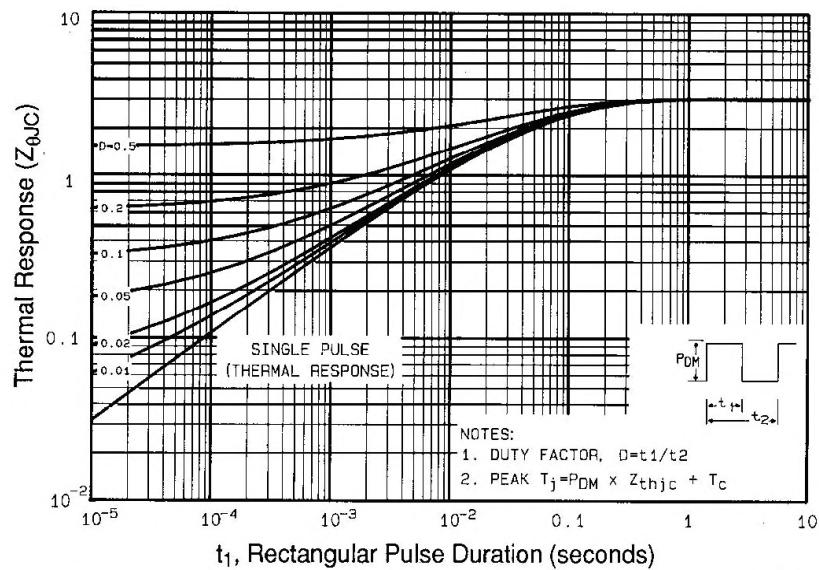


Fig. 10b - Switching Time Waveforms



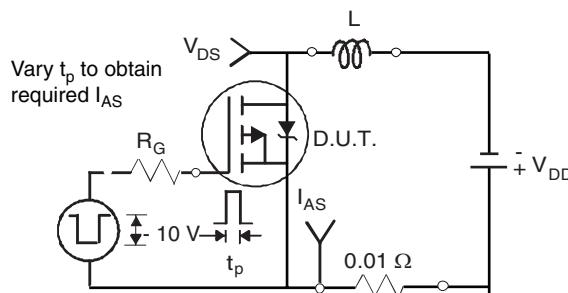


Fig. 12a - Unclamped Inductive Test Circuit

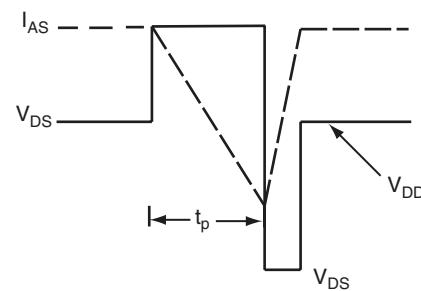


Fig. 12b - Unclamped Inductive Waveforms

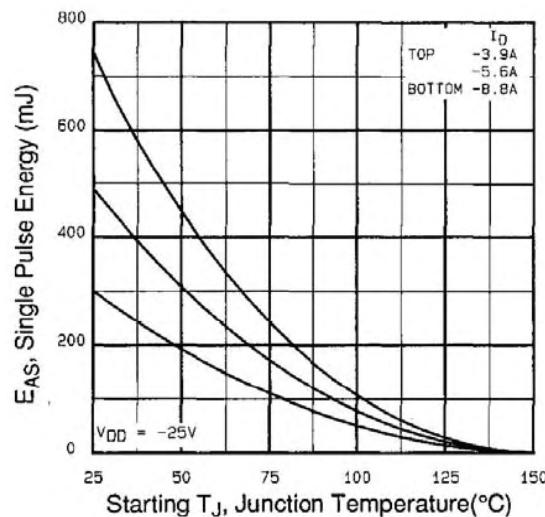


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

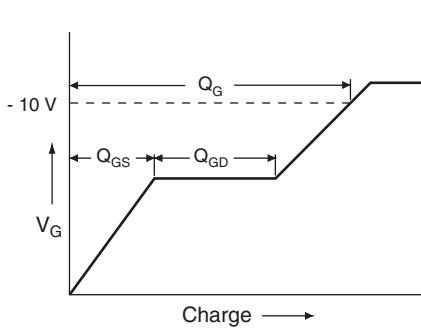


Fig. 13a - Basic Gate Charge Waveform

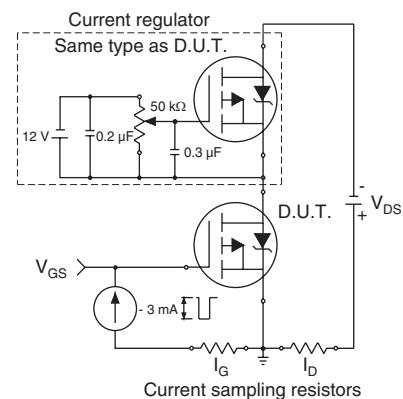


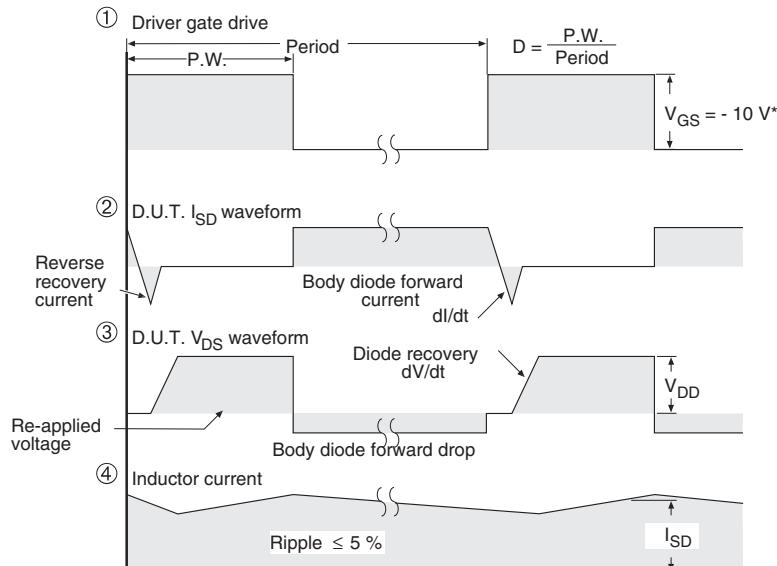
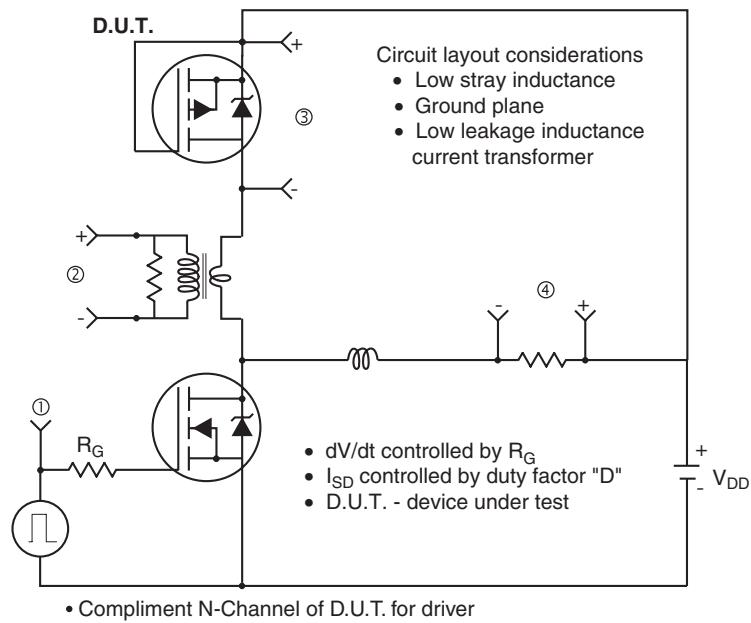
Fig. 13b - Gate Charge Test Circuit



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IRFR9024, IRFU9024, SiHFR9024, SiHFU9024

Peak Diode Recovery dV/dt Test Circuit



* $V_{GS} = -5 \text{ V}$ for logic level and -3 V drive devices

Fig. 14 - For P-Channel